


<b>Search Notes</b> 	<b>Application/Control No.</b> 10539377	<b>Applicant(s)/Patent Under Reexamination</b> BEVAN ET AL.
	<b>Examiner</b> JON M LOCKARD	<b>Art Unit</b> 1647

SEARCHED			
Class	Subclass	Date	Examiner
NONE		2/18/08	JML

SEARCH NOTES		
Search Notes	Date	Examiner
STIC Search of SEQ ID NO:2. See sequence search results in SCORE.	2/15/08	JML
EAST Search (USPAT, US-PGPUB, EPO, DERWENT): See attached search history.	2/18/08	JML
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See attached search history.	2/18/08	JML
PALM: Inventor search.	2/18/08	JML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	STIC Search of SEQ ID NO:2. See sequence search results in SCORE.	7/21/08	JML
	EAST Search (USPAT, US-PGPUB): See attached search history.	8/13/08	JML
	PALM: Inventor search.	8/13/08	JML

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